Notice of References Cited Application/Control No. 10/725,210 Applicant(s)/Patent Under Reexamination SEIDEL ET AL. Examiner David Buttner Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,838,518	01-2005	Seidel et al.	525/67
	В	US-6,423,766	07-2002	Itagaki, Hiroshi	524/127
	С	US-5,871,570	02-1999	Koyama et al.	106/18.18
	D	US-5,314,949	05-1994	Kozakura et al.	525/67
	E	US-5,258,432	11-1993	Ogoe et al.	524/141
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-		,	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	z	JP-2001226576	08-2001	JP ·	Nanba .	
	0					
	Ω					
	σ					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.